## NTT-AT GaN HEMT epiwafer on Si/SiC/Sapphire/GaN



# Applications Power electronics

Switching devices (AC-DC/DC-DC converter, Motor, Automobile)

### **High-frequency communication systems**

Power amplifier (Wireless system base station)

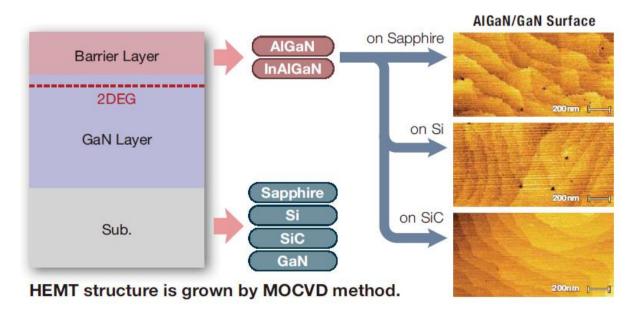
#### **Benefit**

High power density; High efficiency; Small figure; Low cost

#### **GaN HEMT Epi Products**

Epi	Size	Substrate
AlGaN/GaN HEMT Epi	2~4 inch	Sapphire
	2∼6 inch	Si
	2~4 inch	SiC
	2 inch	GaN

#### Layer Structure and AFM Images of HEMT epi suface



# GaN on Si Layer Structure

Cap Layer				
Material	GaN			
Doping	Doped or un-doped			
Thickness	0-5 (nm)			
Barrier				
Material	AlGaN			
Al content	10-50%			
Doping	Doped or un-doped			
Thickness	<50 (nm)			
Buffer				
Material	(AI) GaN			
Thickness	1-5 ( μ m)			
Features				
Sheet resistance: 200-800 Ohm/sq.				
Sheet carrier density: 5E12-2E13 (cm <sup>-2</sup> )				
Electron mobility: 1,200-2,200 cm <sup>2</sup> /Vs				
Breakdown voltage: 200-1800 V (depending on the device structure)				